

N channel 70V MOSFET

1. Description

The HS1018E is the N-Channel logic enhancement mode power field effect transistors are produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance.

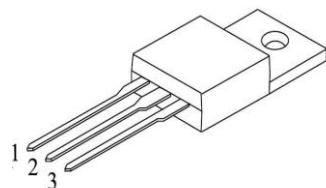
2. Feature

- $R_{DS(ON)} \leq 6.8\text{m}\Omega @ V_{GS} = 10\text{V}$
- Super high density cell design for extremely low $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability

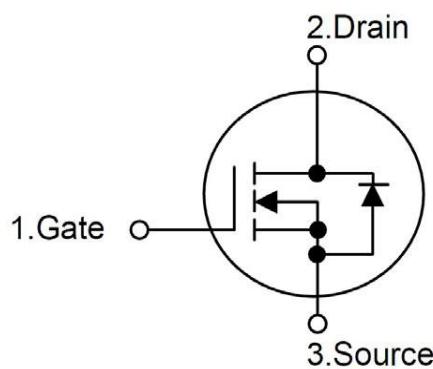
V _{DS}	70	V
R _{DS(on)}	6.8	mΩ
I _D	90	A

3. Pin configuration

Order Number	Package
HS1018E	TO-220



TO-220



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4. Absolute maximum ratings (Tc=25°C Unless Otherwise Noted)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DSS}	70	V
Gate-Source Voltage		V _{DSS}	±20	V
Continuous Drain Current	Tc=25°C	ID	90	A
	Tc=70°C		75	A
Pulsed Drain Current		I _{DM}	355	A
Power Dissipation	Tc=25°C	PD	200	W
	Tc=70°C		140	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to 175	°C

5. Thermal characteristics

Parameter	Symbol	Ratings	Units
Thermal resistance, case to sink typ.	R _{thCS}	0.5	°C/W
Thermal resistance junction to case.	R _{thJC}	0.75	°C/W
Thermal resistance junction to ambient.	R _{thJC}	62.5	°C/W

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6. Electrical characteristics ($T_A = 25^\circ C$ Unless Otherwise Specified)

Symbol	Parameter	Limit	Min	Typ	Max	Unit
STATIC						
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	70			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	2		4	V
I _{GSS}	Gate-Body Leakage	V _{DS} =0V, V _{GS} =±20V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =70V, V _{GS} =0V			1	μA
R _{D(S(ON))}	Drain-Source On-Resistance*	V _{GS} =10V, I _D =40A		5.8	6.8	mΩ
V _{SD}	Diode Forward Voltage *	I _S =40A, V _{GS} =0V		1	1.3	V
DYNAMIC						
Q _g	Total Gate Charge	V _{DD} =48V, V _{GS} =10V, I _D =50A		83		Nc
Q _g	Total Gate Charge			20		
Q _{gs}	Gate-Source Charge	V _{DD} =48V, V _{GS} =4.5V, I _D =50A		24		
Q _{gd}	Gate-Drain Charge			26		
R _g	Gate Resistance	V _{DS} =0V, V _{GS} =0V, f=1MHz		0.8		Ω
C _{iss}	Input Capacitance			4650		pF
C _{oss}	Output Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz		312		
C _{rss}	Reverse Transfer Capacitance			220		
t _{d(on)}	Turn-On Delay Time			39		ns
t _r	Turn-On Rise Time	V _{GS} =10V, R _L =30Ω		13		
t _{d(off)}	Turn-Off Delay Time	V _{DD} =30V, R _G =3.6Ω		84		
t _f	Turn-Off Fall Time			13		

Notes :a. pulse test:pulse width ≤ 300 us,duty cycle 2% ,Guaranteed by design,not subject to production testing.

b. HOMSEMI reserves the right to improve product design,functions and reliability without notice.

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